3	earcn	Motes	
		PART CLERO CENER (

Application/Control No.	Applicant(s)/Patent und Reexamination	ier
10/689,192	KWON ET AL.	
Examiner	Art Unit	
David Sample	1755	

SEARCHED					
Class	Subclass	Di	Дө	Exa	mlner
264	40.1	3/30/2005		ON	
·	604				
	662				
	663	·			
	664				
	674				
	235				
	346				
501	103				
	126				
	152	3/30/	2005	\mathcal{G}	es :
					=
UPDA	TED	9/20/	2005	Q	
UPDA UPDA	TED	2/15/	2006	0	21

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
SAME A	S ABOVE	2/15/2006	PES	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East searched .	3/30/2005	H	
Inventor name search	3/30/2005	Al	
Parent App. Reviewerd	3/20/2001	OS	
EAST SEARCH UPDATED	9/20/2005	QQ)	
		•	